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		FOREIGN P	PATENT	DOCUM	IENTS			
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/IP/	1	JP A 5-260610	10/08/1993		Japan	x		x
/IP/	2	JP A 2002-017004 01	01/18/2002		Japan	х		х
		ОТНЕ	ER DOC	UMENT	S			
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INITIAL	<u> </u>	DOCUMENT NUMBER		DATE	NAME			CLASS	CLASS
/IP/s	1.	US 2003/0081440 A1	05/	01/2003	Masayuki KOMATSU et	et al.			
/IP/	2.	US 2004/0165868 A1	08/26/2004		Eiji SATO et al.				
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/IP/	6.	JP-A-02-308935 w/ abst.	12/21/1990		JAPAN				
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